

<b>Notice of References Cited</b>	Application/Control No. 10/658,973	Applicant(s)/Patent Under Reexamination FUJISAWA ET AL.	
	Examiner Minh-Loan T. Tran	Art Unit 2826	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,475,241	12-1995	Harrah et al.	257/99
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-61-067,971	04-1986	Japan	Ochiai, Yasuhiko	H01L 33/00
	O	JP-60-098,687	06-1985	Japan	Inoue, Kiyoshi	H01L 33/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.